

Certified Reference Material

Product ID: MBH-11X 15309 T

Product Description: Cast Iron with Chrome

Description and Intended Use: This Certified Reference Material is covered under the scope of accreditation to ISO 17034 by LGC Standards - Manchester, NH. As an ISO 17034 certified reference material, appropriate use of this material will fulfill the certified reference material and traceability requirements for use in ISO 17025 accredited laboratories. This CRM may come in the form of a solid disk, or chips. The intended use of this CRM may include, but is not limited to, the calibration of instruments and the validation of analytical methods. • ··• ··· · · · · · · · · · · ·

	Certified Values listed in wt.% with associated uncertainties													
Al	0.097	± 0.0	09	С	3.18	± 0.05	Co	0.76	± 0.003	Cr	24.9	± 0.2		
Cu	0.056	± 0.0	02	Mn	1.53	± 0.04	Мо	0.066	± 0.003	Nb	0.056	± 0.004		
Ni	0.152	± 0.0	04	Р	0.034	± 0.002	S	0.021	± 0.002	Si	1.22	± 0.02		
Sn	0.0047	± 0.0	006	Ti	0.013	± 0.001	V	0.098	± 0.002	W	0.022	± 0.002		
	Indicative Values listed in ppm													
As	(40)	В	(<2)	Fe	(68%)	Mg	(200)	N <(730) O	(<100)	Pb	(10)		
Sb	(10)	Zn	(50)	Zr	(12)									

Homogeneity and Uncertainty: "Uncertainty" values, as reported adjacent to certified concentration values, are based on a 95% Confidence Interval. These estimated uncertainties include the combined effects of method imprecision, material inhomogeneity, and any bias between methods. Homogeneity data from experimental XRF results are reflected in both the overall statistics and certified data. Homogeneity samples are selected by a systematic sampling procedure. The number of samples may be determined by equation 1, where Nprod is the number of units produced and Nmin is the number of samples used for homogeneity testing. These samples are arranged in a simple randomized design such that each sample is analyzed multiple times by XRF. Homogeneity may also be determined within sample using an applied version of ASTM E826. A single factor ANOVA is used to calculated uncertainty due to inhomogeneity (Uhom). Uncertainty of the material is calculated by equation 2, where H=U_{hom}, S= Standard deviation, t= t-value at 95% CI, and n= number of observations.

$$1.N_{MIN} = \max(10, \sqrt[3]{N_{PROD}})$$

2.
$$U_{CRM} = \frac{\sqrt{H^2 + S^2}}{\sqrt{n}} * t$$

Certification Laboratories: Much of the analytical work performed to assess this material has been carried out by laboratories with proven competence, as indicated by their accreditation to ISO 17025. It is an implicit requirement for this accreditation that analytical work should be performed with due traceability, via an unbroken chain of comparisons, each with stated uncertainty, to primary standards such as the mole, or to nationally- or internationally-recognised reference materials. Of the individual results herein, some have traceability (to the mole) via primary analytical methods. Some are traceable to substances of known stoichiometry. Most have traceability via commercial solutions. Furthermore, some results have additional traceability to NIST standards, as part of the analytical calibration or process control.

LGC Standards - Manchester, NH . IMR Test Labs - Lansing, NY

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- Cleveland Cliffs Middletown, OH
- Connecticut Metallurgical, Inc. East Hartford, CT . Applied Technical Services - Marietta, GA
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- NSL Analytical Services Cleveland, OH SGS MSi - Melrose Park, IL
- EAG Laboratories Liverpool, NY
- - . Scrooby's Laboratory Service - Rynfield, South Africa
- Element Materials Technology Middlesbrough, UK New Hampshire Materials Laboratory - Somersworth, NH
- RSML Bengaluru, India
- Instructions for Use: The test surface is on the opposite side of the labeled surface, which includes the material identification. This material is individually chill cast per piece. This manner of casting can cause the formation of inhomogeneous segregates in the upper, engraved portion of the disk. Therefore, the certification information above is not applicable to within 3mm of the engraved surface. Each packaged disk has been prepared by finishing the test surface using a lathe. The user must determine the correct surface preparation procedure for each analytical technique. The user is cautioned to use care when either resurfacing the disk or performing additional polishing, as these processes may contaminate the surface. The minimum sample size for chips should be individually evaluated based on the analytical technique used; this would typically be greater than 0.1 grams. The material should be stored in a cool, dry location when not in use. Chips are not recommended for gas analysis.

Period of Validity: The certification of this material is valid indefinitely, within the uncertainty specified, provided the material is handled and stored in accordance with the instructions stated on this certificate. The certification is nullified if the material is damaged, contaminated, otherwise modified, or used in a manner for which it was not intended.

Kimberly Halkiotis, Global Product Manager

February 17, 2022 Certification Date



ISO 17034 Accredited: Reference Materials Producer, Certificate # 2848.02 ISO/IEC 17025 Accredited: Chemical Testing. Certificate # 2848.01

Conditions of Sale and Supply: All CRMs & RMs sold are subject to applicable LGC Standard Terms and Conditions of Sale.





The following data represents all pertinent information reported as it applies to the chemical characterization of this material.

	Al	As	В	C	Co	Cr	Cu	Fe	Mg	Mn	Мо	N	Nb
1	0.0710	0.0003	0.0002	3.0650	0.0650	24.220	0.0480	67.500	0.0001	1.4140	0.0540	0.0720	0.0410
2	0.0765	0.0011	0.0003	3.0700	0.0701	24.433	0.0500	68.050	0.0020	1.4240	0.0580	0.0730	0.0470
3	0.0780	0.0024	<0.00010	3.0800	0.0720	24.450	0.0501	68.703	0.0030	1.4270	0.0611		0.0474
4	0.0790	0.0067		3.0950	0.0720	24.471	0.0539	69.000	0.0110	1.4600	0.0624		0.0502
5	0.0870	0.0070		3.1500	0.0736	24.500	0.0540		0.0220	1.4910	0.0633		0.0530
6	0.0890	<0.002		3.1730	0.0740	24.540	0.0550		0.0600	1.5090	0.0660		0.0550
7	0.0910	<0.002		3.1930	0.0740	24.570	0.0552		<0.0005	1.5140	0.0660		0.0551
8	0.0920	<0.002		3.1983	0.0740	24.620	0.0560		< 0.001	1.5450	0.0670		0.0566
9	0.0936	<0.005		3.1990	0.0748	24.623	0.0580		<0.0010	1.5490	0.0675		0.0570
10	0.0940	<0.0050		3.2000	0.0770	24.738	0.0580		<0.0010	1.5780	0.0680		0.0592
11	0.0957			3.2460	0.0775	24.740	0.0580		< 0.005	1.5820	0.0685		0.0600
12	0.0976			3.2760	0.0788	24.999	0.0587		<0.01	1.5869	0.0690		0.0600
13	0.1000			3.2870	0.0790	25.058	0.0590			1.6000	0.0694		0.0616
14	0.1010			3.2970	0.0806	25.156	0.0602			1.6100	0.0700		0.0620
15	0.1152				0.0830	25.200	0.0603			1.6110	0.0704		0.0647
16	0.1160				0.0840	25.360	0.0620			1.6200	0.0718		0.0650
17	0.1178				0.0840	25.470					0.0750		0.0650
18	0.1200					25.530							
19	0.1212					25.750							
Mean	0.0966	0.0035	0.0002	3.1807	0.0761	24.865	0.0560	68.313	0.0164	1.5326	0.0663	0.0725	0.0565
STDV	0.0154	0.0032	0.0000	0.0801	0.0052	0.4406	0.0040	0.6719	0.0229	0.0717	0.0052	0.0007	0.0069
Certified	0.097	(0.004)	(<0.0002)	3.18	0.076	24.9	0.056	(68)	(0.02)	1.53	0.066	(<0.073)	0.056
	0.009			0.05	0.003	0.2	0.002			0.04	0.003		0.004
Methods	I,O,G,IM,X	IM,I,O,X	IM,I,O	C,G,O,X,I	I,O,G,IM,X	I,O,G,X	I,O,IM,X	I,O,X	I,O,G,IM,X	I,O,X	I,O,IM,X	F	I,O,IM,X

	Ni	0	Р	Pb	S	Sb	Si	Sn	Ti	V	W	Zn	Zr
1	0.1350	0.0015	0.0300	0.0001	0.0140	0.0001	1.1510	0.0030	0.0073	0.0940	0.0150	0.0012	0.0010
2	0.1360	0.0140	0.0300	0.0002	0.0170	0.0001	1.1700	0.0036	0.0080	0.0940	0.0160	0.0013	0.0003
3	0.1430		0.0300	0.0011	0.0177	0.0012	1.1830	0.0038	0.0101	0.0955	0.0180	0.0025	0.0009
4	0.1440		0.0306	0.0019	0.0180	0.0025	1.2000	0.0048	0.0108	0.0960	0.0200	0.0040	0.0019
5	0.1470		0.0310	<0.001	0.0184	<0.0001	1.2050	0.0050	0.0110	0.0970	0.0218	0.0090	0.0021
6	0.1470		0.0320	<0.0010	0.0200	<0.0010	1.2051	0.0050	0.0127	0.0974	0.0227	0.0098	<0.0005
7	0.1493		0.0330	<0.002	0.0200	<0.0020	1.2133	0.0050	0.0127	0.0990	0.0230	0.0100	<0.0010
8	0.1520		0.0330	<0.002	0.0201		1.2280	0.0051	0.0130	0.0991	0.0230	<0.001	< 0.002
9	0.1540		0.0334	<0.002	0.0201		1.2290	0.0051	0.0131	0.0994	0.0230	<0.0010	< 0.0050
10	0.1540		0.0338	<0.0020	0.0210		1.2370	0.0054	0.0140	0.0998	0.0230	<0.005	<0.01
11	0.1550		0.0350	< 0.005	0.0210		1.2440	0.0060	0.0140	0.1000	0.0250		
12	0.1570		0.0351		0.0211		1.2480	<0.0020	0.0150	0.1012	0.0257		
13	0.1580		0.0360		0.0220		1.2504		0.0150	0.1017	0.0260		
14	0.1590		0.0363		0.0232		1.2520		0.0150	0.1040	0.0291		
15	0.1592		0.0370		0.0239		1.2550		0.0159				
16	0.1600		0.0402		0.0260				0.0160				
17	0.1618				0.0260				0.0160				
18	0.1690				0.0270								
19													
Mean	0.1522	0.0078	0.0335	0.0008	0.0209	0.0010	1.2181	0.0047	0.0129	0.0984	0.0222	0.0054	0.0012
STDV	0.0090	0.0088	0.0029	0.0008	0.0034	0.0011	0.0321	0.0009	0.0027	0.0029	0.0039	0.0040	0.0008
Certified	0.152	(<0.01)	0.034	(0.001)	0.021	(0.001)	1.22	0.0047	0.013	0.098	0.022	(0.005)	(0.0012)
UCRM	0.004		0.002		0.002		0.02	0.0006	0.001	0.002	0.002		
Methods	I,O,G,IM,X	F	I,O,G,IM,X	I,IM,O,X	C,G,O,X	IM,O	I,O,G,X	I,IM,O,X	I,O,G,IM,X	I,O,IM,X	O,I,G,IM,X	I,IM,X,O	I,O,IM,X

Legend: W = Classical, C = Combustion, F = Fusion, A = AA or GFAA, I = ICP or DCP, IM=ICP-MS, D = DC Arc, O = AES, X = XRF, G = GDAES or GDMS, H = Hollow Cathode AES

